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April 2014

# **FDPC8014S**

## PowerTrench® Power Clip 25V Asymmetric Dual N-Channel MOSFET

#### **Features**

Q1: N-Channel

- $\blacksquare$  Max  $r_{DS(on)}$  = 3.8 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_{D}$  = 20 A
- Max  $r_{DS(on)} = 4.7 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 18 \text{ A}$

Q2: N-Channel

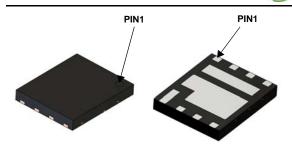
- Max  $r_{DS(on)} = 1.2 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 41 \text{ A}$
- Max  $r_{DS(on)}$  = 1.4 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 37 A
- Low inductance packaging shortens rise/fall times, resulting in lower switching losses
- MOSFET integration enables optimum layout for lower circuit inductance and reduced switch node ringing
- RoHS Compliant

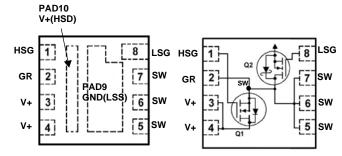
#### **General Description**

This device includes two specialized N-Channel MOSFETs in a dual package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFET<sup>TM</sup> (Q2) have been designed to provide optimal power efficiency.

#### **Applications**

- Computing
- Communications
- General Purpose Point of Load





Top	Power Clip 5X6	Bottom

Pin	Name	Description	Pin	Name	Description	Pin	Name	Description
1	HSG	High Side Gate	3,4,10	V+(HSD)	High Side Drain	8	LSG	Low Side Gate
2	GR	Gate Return	5,6,7	SW	Switching Node, Low Side Drain	9	GND(LSS)	Low Side Source

#### **MOSFET Maximum Ratings** T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
$V_{DS}$	Drain to Source Voltage		25 <sup>Note5</sup>	25	V
$V_{GS}$	Gate to Source Voltage		±12	±12	V
	Drain Current -Continuous	T <sub>C</sub> = 25 °C	60	110	
$I_D$	-Continuous	T <sub>A</sub> = 25 °C	20 <sup>Note1a</sup>	41 <sup>Note1b</sup>	Α
	-Pulsed	T <sub>A</sub> = 25 °C (Note 4)	75	160	
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 3)	73	253	mJ
E <sub>AS</sub>	Power Dissipation for Single Operation	T <sub>C</sub> = 25 °C	21	42	W
	Power Dissipation for Single Operation	T <sub>A</sub> = 25 °C	2.1 <sup>Note1a</sup>	2.3 Note1b	VV
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to	+150	°C

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	6.0	3.0	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	60 <sup>Note1a</sup>	55 <sup>Note1b</sup>	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	130 <sup>Note1c</sup>	120 <sup>Note1d</sup>	

## **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
05OD/16OD	FDPC8014S	Power Clip 56	13 "	12 mm	3000 units

# **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	acteristics						
D\/	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	Q1	25			V
DVDSS		$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	Q2	25			V
$\Delta BV_{DSS}$	Breakdown Voltage Temperature	I <sub>D</sub> = 250 μA, referenced to 25 °C	Q1		24		mV/°C
$\Delta T_{J}$	Coefficient	$I_D$ = 10 mA, referenced to 25 °C	Q2		24		IIIV/ C
ı	Zoro Coto Voltago Proin Current	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	Q1			1	μΑ
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	Q2			500	μΑ
1	Gate to Source Leakage Current,	V <sub>GS</sub> = 12 V/-8 V, V <sub>DS</sub> = 0 V	Q1			±100	nA
I <sub>GSS</sub>	Forward	$V_{GS} = 12 \text{ V/-8 V}, V_{DS} = 0 \text{ V}$	Q2			±100	nA

#### **On Characteristics**

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = 1 mA$	Q1 Q2	0.8 1.1	1.3 1.4	2.5 2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{.I}}$	Gate to Source Threshold Voltage	$I_D$ = 250 $\mu$ A, referenced to 25 °C	Q1		-4		mV/°C
$\Delta T_{J}$	Temperature Coefficient	I <sub>D</sub> = 10 mA, referenced to 25 °C	Q2		-3		11117
	Drain to Source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 20 A			2.8	3.8	
		$V_{GS} = 4.5 \text{ V}, I_D = 18 \text{ A}$	Q1		3.4	4.7	
r		$V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}, T_{J} = 125 \text{ °C}$			3.9	5.3	mΩ
r <sub>DS(on)</sub>		$V_{GS} = 10V, I_D = 41 A$			0.9	1.2	11122
		$V_{GS} = 4.5 \text{ V}, I_D = 37 \text{ A}$	Q2		1.0	1.4	
		$V_{GS} = 10 \text{ V}, I_D = 41 \text{ A}, T_J = 125 ^{\circ}\text{C}$			1.1	1.5	
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 20 \text{ A}$	Q1		182		S
	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 41 \text{ A}$	Q2		315		3

#### **Dynamic Characteristics**

-							
C <sub>iss</sub>	Input Capacitance	Q1:	Q1 Q2		1695 6580	2375 9870	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 13 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$ $Q2:$	Q1 Q2		495 1720	710 2580	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	$V_{DS} = 13 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$	Q1 Q2		54 204	100 370	pF
R <sub>g</sub>	Gate Resistance		Q1 Q2	0.1 0.1	0.4 0.4	1.2 1.2	Ω

### **Switching Characteristics**

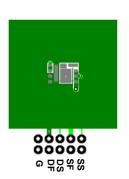
t <sub>d(on)</sub>	Turn-On Delay Time		Q1 Q2	8 16	16 28	ns
t <sub>r</sub>	Rise Time	Q1: V <sub>DD</sub> = 13 V, I <sub>D</sub> = 20 A, R <sub>GEN</sub> = 6	Ω1 Q2	2 6	10 11	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	Q2: V <sub>DD</sub> = 13 V, I <sub>D</sub> = 41 A, R <sub>GEN</sub> = 6	Q1 Q2	24 47	38 75	ns
t <sub>f</sub>	Fall Time	VDD = 10 V, 10 = 417, NGEN = 0.	Q1 Q2	2 4	10 10	ns
Q <sub>g</sub>	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V	Q1 Q2	25 93	35 130	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 13 \text{ V, I}$ $= 20 \text{ A}$	Q1 Q2	11 43	16 60	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	Q2 V <sub>DD</sub> = 13 V, I	Q1 D Q2	3.4 13		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	= 41 A	Q1 Q2	2.2 8.5		nC

## Electrical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

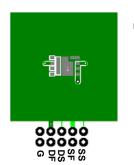
Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Units
Drain-Soເ	rce Diode Characteristics						
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V, } I_S = 20 \text{ A}$ (Note 2) $V_{GS} = 0 \text{ V, } I_S = 41 \text{ A}$ (Note 2)	Q1 Q2		0.8 0.8	1.2 1.2	V
I <sub>S</sub>	Diode continuous forward current	T _ 25 °C	Q1 Q2		60 110		А
I <sub>S,Pulse</sub>	Diode pulse current	-T <sub>C</sub> = 25 °C	Q1 Q2		75 160		А
t <sub>rr</sub>	Reverse Recovery Time	Q1 I <sub>F</sub> = 20 A, di/dt = 100 A/μs	Q1 Q2		25 36	40 58	ns
Q <sub>rr</sub>	Reverse Recovery Charge	Q2 $I_F = 41 \text{ A, di/dt} = 300 \text{ A/}\mu\text{s}$	Q1 Q2		10 47	20 75	nC

#### Notes

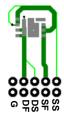
 $1.R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



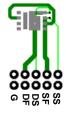
a. 60 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 55 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



c. 130 °C/W when mounted on a minimum pad of 2 oz copper



d. 120 °C/W when mounted on a minimum pad of 2 oz copper

- 2 Pulse Test: Pulse Width < 300  $\mu\text{s},$  Duty cycle < 2.0%.
- 3. Q1 : E<sub>AS</sub> of 73 mJ is based on starting T<sub>J</sub> = 25  $^{\rm o}$ C; N-ch: L = 3 mH, I<sub>AS</sub> = 7 A, V<sub>DD</sub> = 30 V, V<sub>GS</sub> = 10 V. 100% test at L= 0.1 mH, I<sub>AS</sub> = 24 A. Q2: E<sub>AS</sub> of 253 mJ is based on starting T<sub>J</sub> = 25  $^{\rm o}$ C; N-ch: L = 3 mH, I<sub>AS</sub> = 13 A, V<sub>DD</sub> = 25 V, V<sub>GS</sub> = 10 V. 100% test at L= 0.1 mH, I<sub>AS</sub> = 43 A.
- 4. Pulsed Id limited by junction temperature,td<=10 us. Please refer to SOA curve for more details.
- 5. The continuous  $V_{DS}$  rating is 25 V; However, a pulse of 30 V peak voltage for no longer than 100 ns duration at 600 KHz frequency can be applied.

## Typical Characteristics (Q1 N-Channel) T<sub>J</sub> = 25°C unless otherwise noted

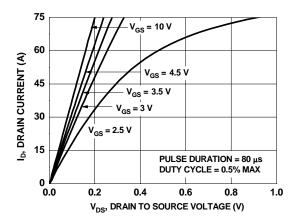


Figure 1. On Region Characteristics

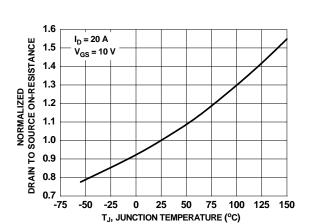


Figure 3. Normalized On Resistance vs. Junction Temperature

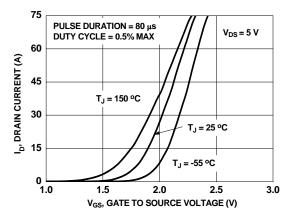


Figure 5. Transfer Characteristics

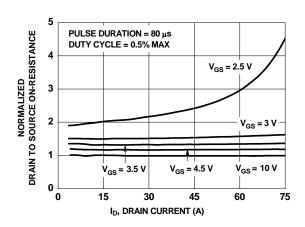


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

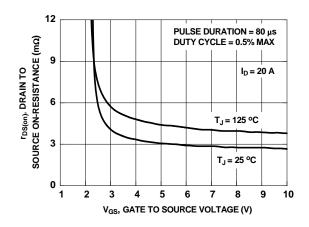


Figure 4. On-Resistance vs. Gate to Source Voltage

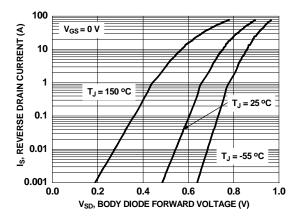


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

## Typical Characteristics (Q1 N-Channel) T<sub>J</sub> = 25°C unless otherwise noted

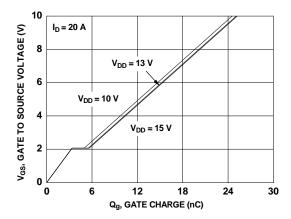


Figure 7. Gate Charge Characteristics

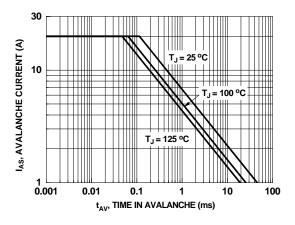


Figure 9. Unclamped Inductive Switching Capability

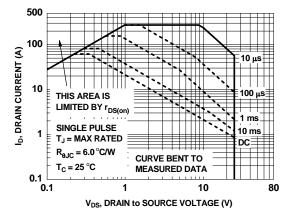


Figure 11. Forward Bias Safe Operating Area

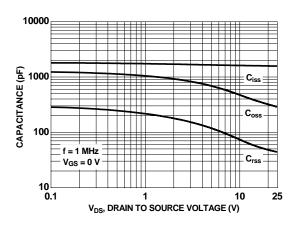


Figure 8. Capacitance vs. Drain to Source Voltage

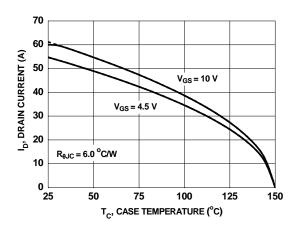


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

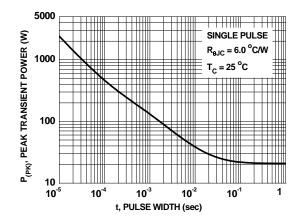


Figure 12. Single Pulse Maximum Power Dissipation

5

# Typical Characteristics (Q1 N-Channel) $T_J = 25$ °C unless otherwise noted

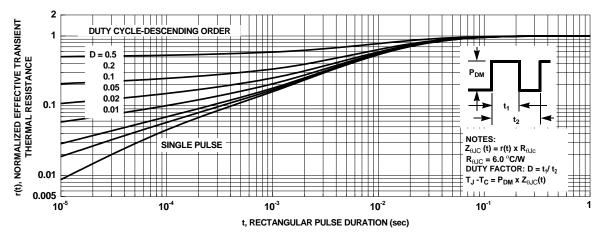


Figure 13. Junction-to-Case Transient Thermal Response Curve

## Typical Characteristics (Q2 N-Channel) T<sub>J</sub> = 25 °C unless otherwise noted

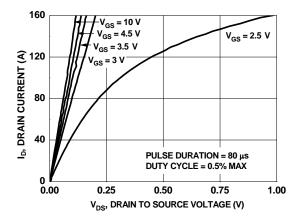


Figure 14. On- Region Characteristics

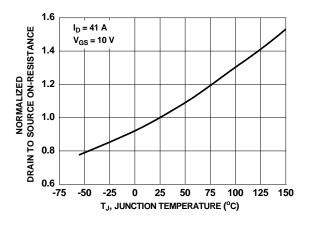


Figure 16. Normalized On-Resistance vs. Junction Temperature

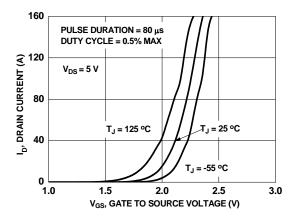


Figure 18. Transfer Characteristics

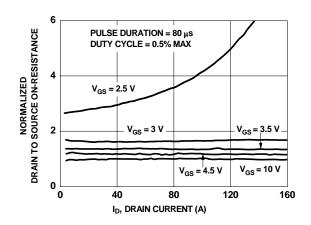


Figure 15. Normalized on-Resistance vs. Drain Current and Gate Voltage

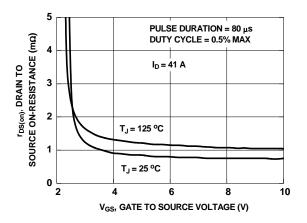


Figure 17. On-Resistance vs. Gate to Source Voltage

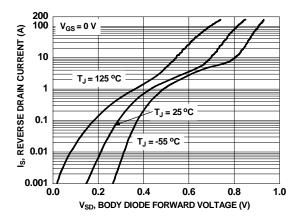


Figure 19. Source to Drain Diode Forward Voltage vs. Source Current

### Typical Characteristics (Q2 N-Channel) T<sub>J</sub> = 25°C unless otherwise noted

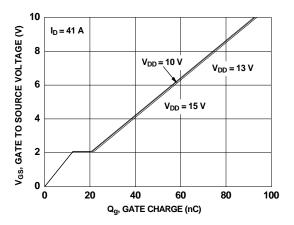


Figure 20. Gate Charge Characteristics

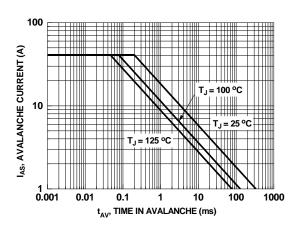


Figure 22. Unclamped Inductive Switching Capability

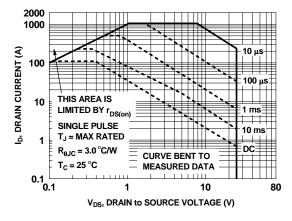


Figure 24. Forward Bias Safe Operating Area

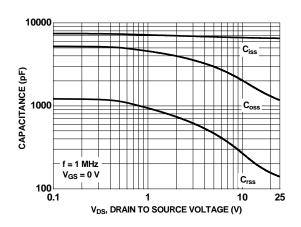


Figure 21. Capacitance vs. Drain to Source Voltage

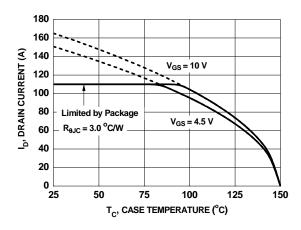


Figure 23. Maximum Continuous Drain Current vs. Case Temperature

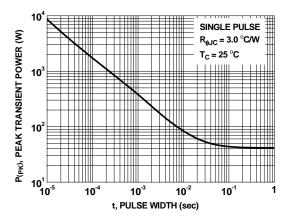


Figure 25. Single Pulse Maximum Power Dissipation

# Typical Characteristics (Q2 N-Channel) $T_J = 25$ °C unless otherwise noted

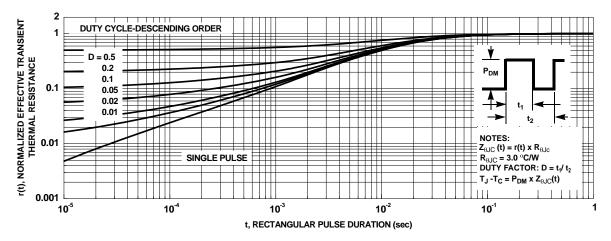


Figure 26. Junction-to-Case Transient Thermal Response Curve

## **Typical Characteristics** (continued)

# SyncFET<sup>TM</sup> Schottky body diode Characteristics

Fairchild's SyncFET<sup>TM</sup> process embeds a Schottky diode in parallel with PowerTrench<sup>®</sup> MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 27 shows the reverses recovery characteristic of the FDPC8014S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

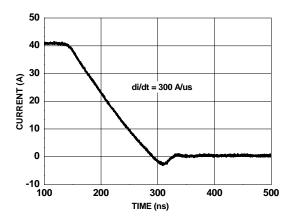


Figure 27. FDPC8014S SyncFET<sup>TM</sup> Body Diode Reverse Recovery Characteristic

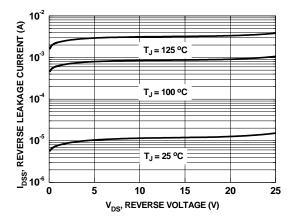
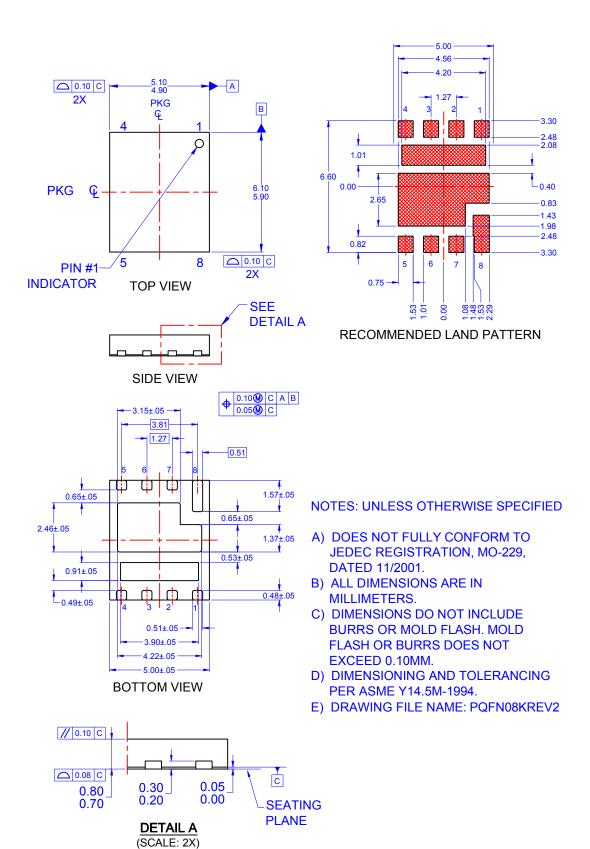


Figure 28. SyncFET<sup>TM</sup> Body Diode Reverse Leakage vs. Drain-source Voltage



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